

<b>Notice of References Cited</b>	Application/Control No. 09/820,509	Applicant(s)/Patent Under Reexamination HUANG ET AL.	
	Examiner William C. Vaughn, Jr.	Art Unit 2143	Page 1 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,829,655	12-2004	Huang et al.	709/248
*	B	US-5,867,688	02-1999	Simmon et al.	709/208
*	C	US-5,862,327	01-1999	Kwang et al.	709/203
*	D	US-5,974,238	10-1999	Chase, Jr., Charlie David	709/248
*	E	US-5,991,771	11-1999	Falls et al.	707/202
*	F	US-6,233,577	05-2001	Ramasubramani et al.	707/9
*	G	US-6,295,541	09-2001	Bodnar et al.	707/203
*	H	US-6,269,369	07-2001	Robertson, Brian D.	707/10
*	I	US-6,317,797	11-2001	Clark et al.	710/5
*	J	US-6,611,849	08-2003	Raff et al.	707/203
*	K	US-6,721,787	04-2004	Hiscock, James Scott	709/217
*	L	US-6,636,873	10-2003	Carini et al.	707/201
*	M	US-5,857,201	01-1999	Wright et al.	707/104.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U <sup>4</sup>	Ding et al., "A Novel Conflict Detection and Resolution Strategy Based on TLRSP in Replicated MOBILE Database Systems", ht 2001
	V <sup>5</sup>	Yee et al., "Scaling Replica Maintenance in Intermittently Synchronized Mobile Databases", 2001
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,000,000	12-1999	Hawkins et al.	707/201
*	B	US-5,831,664	11-1998	Wharton et al.	725/81
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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